Iterative SAFT Reconstruction for Manually Acquired Ultrasonic Measurement Data in Nondestructive Testing

CSP Research Project 19SS

Sayako Kodera Technische Universität Ilmenau



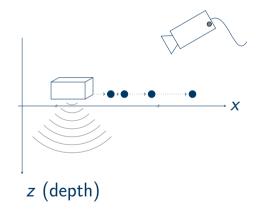


Measurement Assistance System

Features:

- Position recognition
- Data recording
- Data visualization
- Post-processing

Problem: Systematic errors e.g. tracking error

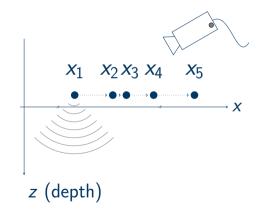


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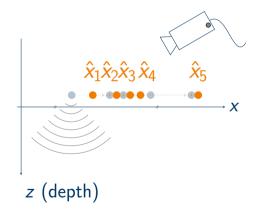


Measurement Assistance System

Features:

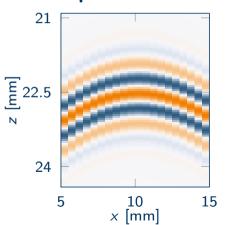
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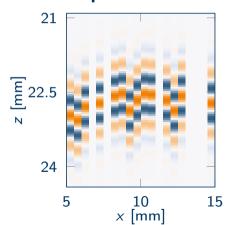


Impact of Position-Inaccuracy

Correct positions

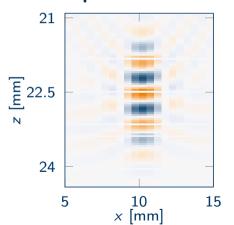


Incorrect positions

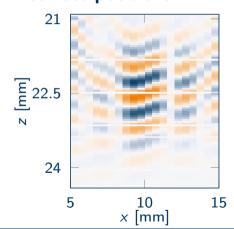


Impact of Position-Inaccuracy

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Incorrect positions



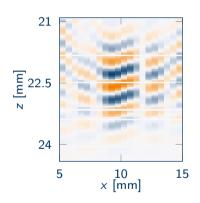
Objective and Contributions

Objective

Artefacts reduction

Contributions

- Spatial approximation of the reconstruction matrix
- Iterative method to correct the positional information



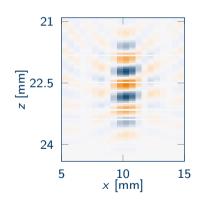
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Artefacts reduction

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Iterative Matrix Improvement

Spatial approximation

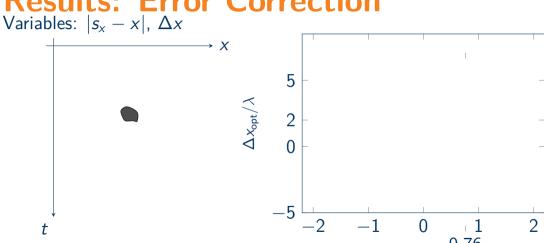
1st order Taylor approximation

Iterative position correction

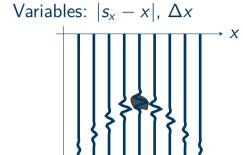
- Solving the least squares problem
- Update the positional information $\hat{x}
 ightarrow \hat{x}_{ ext{opt}}$

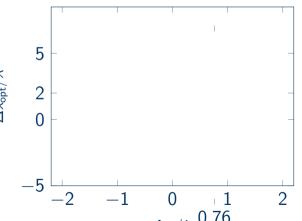
Evaluation criterion

- Error correction $\Delta x_{
 m opt} = x \hat{x}_{
 m opt}$
- Approximation quality $SE^{\dagger}=0~...~1$



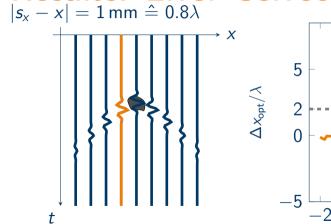
Wavelength $\lambda = 1.26\,\mathrm{mm}$



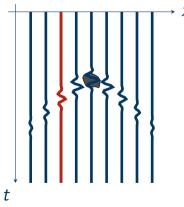


Wavelength $\lambda = 1.26 \, \mathrm{mm}$

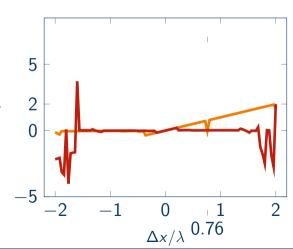
5|8



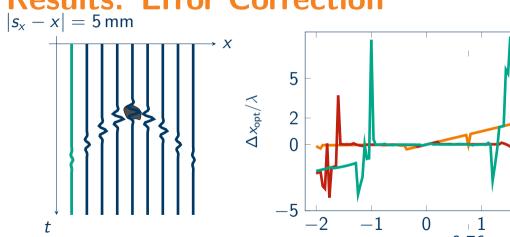
$$|s_{\mathsf{x}} - \mathsf{x}| = 2.5\,\mathsf{mm} \,\,\hat{=}\,\, 1.98\lambda$$



Wavelength $\lambda=1.26\,\mathrm{mm}$

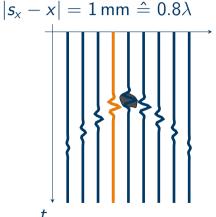


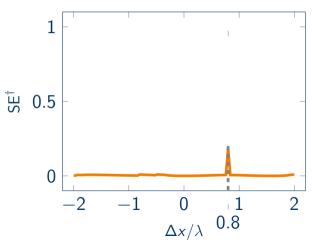
Summary



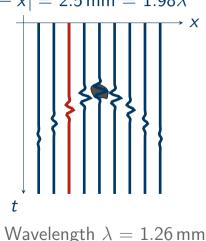
Wavelength $\lambda = 1.26 \, \mathrm{mm}$

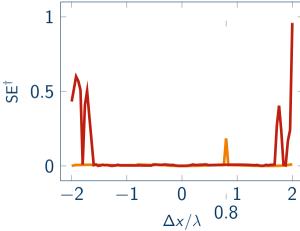
Results: A-Scan Approximation $|s_x - x| = 1 \text{ mm} \triangleq 0.8\lambda$



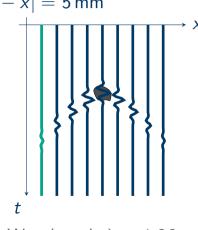


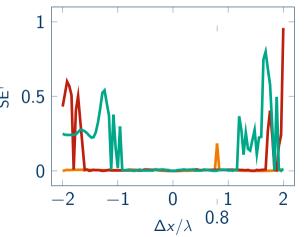
Results: A-Scan Approximation $|s_x - x| = 2.5 \, \text{mm} \, \hat{=} \, 1.98 \lambda$





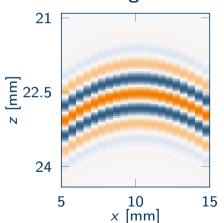
Results: A-Scan Approximation $|s_x - x| = 5 \text{ mm}$



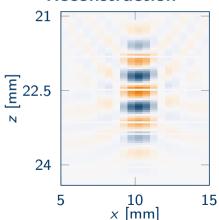


Results: Reconstruction

No tracking error

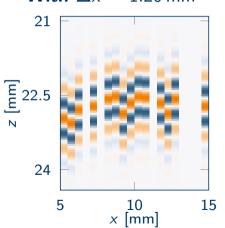


Reconstruction

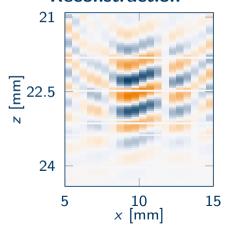


Results: Reconstruction

With $\Delta x = 1.26 \,\mathrm{mm}$

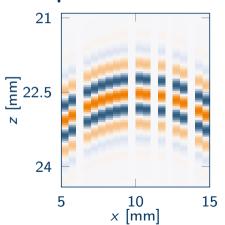


Reconstruction

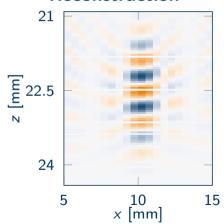


Results: Reconstruction

After position correction



Reconstruction



Conclusion

$ s_X-x $	Position	A-Scan	SAFT Reconstruction
Very close	X		* Less significant
			* Occasional position correction
In-between	/		* Crucial
			* Apply position correction
Far apart			* Out of <i>sight</i> in real
	\approx	\approx	measurements
			* Apply a spatial filter

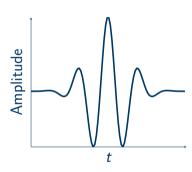
Appendix

Parameters w.r.t. Test Object

Parameter	Value
Material	Aluminium
Dimension $(L \times H)$	$20\mathrm{mm} imes35\mathrm{mm}$
$N_x \times N_z$	40 × 880
Speed of sound c_0	$6300{\rm ms^{-1}}$
Sampling frequency f_S	80 MHz
$dt = rac{1}{f_s}$	12.5 ns
Sampling distance, surface (dx)	0.5 mm
Sampling distance, depth (dz)	39.375 μm

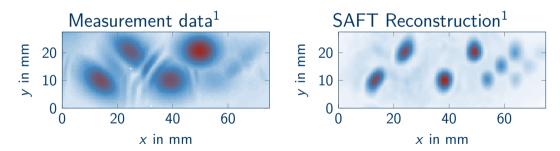
Parameters w.r.t. Pulse

Parameter	Value
Model	Gaussian (Gabor)
Carrier frequency f_c	5 MHz
Wavelength λ	1.26 mm
α	20 (MHz) ²



Reconstructing UT Data

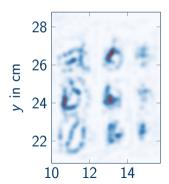
Automatic measurement



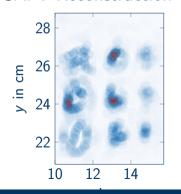
¹F. Krieg et al., SAFT processing for manually acquired ultrasonic measurement data with 3D SmartInspect, *SHM-NDT*, 2018

Reconstructing UT Data

Manual measurement Measurement data¹



SAFT Reconstruction¹



Vertical shift

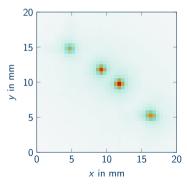
- High impact
- No accessible information

 → only estimation through
 data

Positional inaccuracy

- Less impact
- Critical when sparsely scanned

Equidistant 1600 positions Without systematic errors



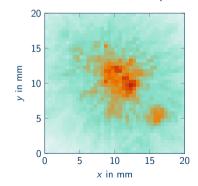
Vertical shift

- High impact

Positional inaccuracy

- Less impact
- Critical when sparsely scanned

Equidistant 1600 positions Vertical shift = $0.3 \, \text{mm} (0.24 \lambda)$



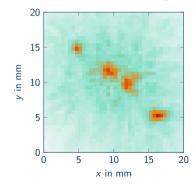
Vertical shift

- High impact

Positional inaccuracy

- Less impact
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1600 random positions Positional error = $2 \text{ mm } (1.6\lambda)$



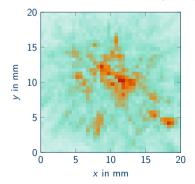
Vertical shift

- High impact

Positional inaccuracy

- Less impact
- Critical when sparsely scanned

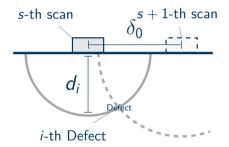
160 random positions Positional error = $2 \text{ mm } (1.6\lambda)$



Post-processing Method

Synthetic Aperture Focusing Technique (SAFT)

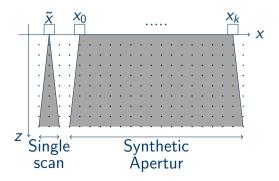
- Superposition according to propagation time delay
- Spatial sampling of the specimen



Post-processing Method

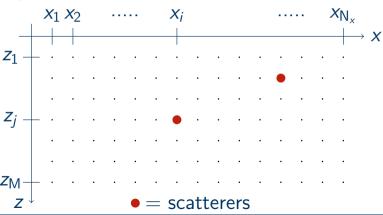
Synthetic Aperture Focusing Technique (SAFT)

- Superposition according to propagation time delay
- Spatial sampling of the specimen





defect map for $ROI = M \times N_x$



Transform: $defect map \rightarrow A-Scan$

$$a(p) = H(p) \cdot b + n$$

- a(p): measured A-Scan at p(M)
- H(p): SAFT matrix at p ($M \times L = M \times M N_x$) Containing pulse information for $s_l = (x_i, z_j)$, l = 1...L
- **b**: vectorized defect map $(L = M N_x)$
- **■** *n*: noise (M)

Transform: $defect map \rightarrow A-Scan$

$$\hat{a}(p) = H(p) \cdot b$$

- $\hat{a}(p)$: modeled A-Scan at p(M)
- H(p): SAFT matrix at p (M × L) Containing pulse information for $s_l = (x_i, z_i), l = 1...L$
- **b**: vectorized defect map (L)

Transform: $defect map \rightarrow A-Scan$

$$m{h}_l(m{p}) = m{H}(m{p}) \cdot m{b}^{(l)}$$

- $h_l(p)$: *l*-th column vector of H(p) (M)
- H(p): SAFT matrix at p (M × L) Containing pulse information for $s_l = (x_i, z_i), l = 1...L$
- **b**^(/): vectorized *defect map* (L)
 Containing single non-zero element in /-th row

Transform: $defect map \rightarrow A-Scan$

$$oldsymbol{h}_l(oldsymbol{p}) = oldsymbol{H}(oldsymbol{p}) \cdot oldsymbol{b}^{(l)}$$

Goal: spatial approximation of SAFT matrix

$$H(p) \approx f(H(p + \Delta p); H'(p + \Delta p); \Delta p)$$

Transform: $defect map \rightarrow A-Scan$

$$m{h}_l(m{p}) = m{H}(m{p}) \cdot m{b}^{(l)}$$

 $M M \times L L$

Transform: scan position \rightarrow A-Scan

$$m{h}_l(m{p})pproxm{h}_l(m{p}+\Deltam{p})-m{J}_{m{h}_l}(m{p}+\Deltam{p})\cdot\Deltam{p}$$

M $M \times K$ K

Transform: $defect map \rightarrow A-Scan$

$$m{h}_l(m{p}) = m{H}(m{p}) \cdot m{b}^{(l)}$$

 $M = M \times I = I$

Transform: scan position \rightarrow A-Scan

$$m{h}_l(m{p})pproxm{h}_l(m{p}+\Deltam{p})- ext{vec}_{\mathsf{M},\mathsf{L}}^{-1}\{m{J}(m{p}+\Deltam{p})\cdot\Deltam{p}\}\cdotm{b}^{(l)}$$

M

 $ML \times K$ K L

Transform: $defect map \rightarrow A-Scan$

$$egin{aligned} oldsymbol{h}_l(oldsymbol{p}) &= oldsymbol{H}(oldsymbol{p}) \cdot oldsymbol{b}^{(l)} \ & oldsymbol{\mathsf{M}} imes oldsymbol{\mathsf{L}} & oldsymbol{\mathsf{L}} \end{aligned}$$

Transform: scan position \rightarrow A-Scan

$$m{H}(m{p})\cdotm{b}_{l}pprox egin{bmatrix} m{H}(m{p}+\Deltam{p})-\mathsf{vec}_{\mathsf{M},\mathsf{L}}^{-1}\{m{J}(m{p}+\Deltam{p})\cdot\Deltam{p}\}ig]\cdotm{b}^{(l)} \ m{M} imesm{L} & m{L} & m{K} & m{L} \ \end{pmatrix}$$

Transform: $defect map \rightarrow A-Scan$

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Spatial approximation of SAFT matrix

$$egin{aligned} m{H}(m{p}) &pprox m{H}(m{p}+\Deltam{p}) - ext{vec}_{\mathsf{M},\mathsf{L}}^{-1} \{ m{J}(m{p}+\Deltam{p}) \cdot \Deltam{p} \} \ & \mathsf{M} imes \mathsf{L} & \mathsf{M} imes \mathsf{K} & \mathsf{K} \end{aligned}$$

Transform: $defect map \rightarrow A-Scan$

$$oldsymbol{h}_l(oldsymbol{p}) = oldsymbol{H}(oldsymbol{p}) \cdot oldsymbol{b}^{(l)}$$
 $oldsymbol{\mathsf{M}} imes oldsymbol{\mathsf{L}}$

Spatial approximation of SAFT matrix p = [x, 0]

$$m{H}(x) pprox m{H}(x + \Delta x) - ext{vec}_{\mathsf{M},\mathsf{L}}^{-1} \{ m{J}(x + \Delta x) \} \cdot \Delta x$$
 $m{M} imes \mathsf{L} \qquad m{M} imes \mathsf{L} \qquad m{M} \, \mathsf{L} imes 1 \qquad 1$

Transform: $defect map \rightarrow A-Scan$

$$oldsymbol{h}_l(oldsymbol{p}) = oldsymbol{H}(oldsymbol{p}) \cdot oldsymbol{b}^{(l)}$$
 $oldsymbol{\mathsf{M}} imes oldsymbol{\mathsf{L}}$

Spatial approximation of SAFT matrix p = [x, 0]

$$H(x) \approx H(x + \Delta x) - H'(x + \Delta x) \cdot \Delta x$$
 $M \times L$
 $M \times L$
 $M \times L$
 1

Inverse vec Operator

$$\mathsf{vec}_{\mathsf{M},\mathsf{L}}^{-1}\{\boldsymbol{J}(\boldsymbol{p}+\Delta\boldsymbol{p})\cdot\Delta\boldsymbol{p}\} = \left[(\mathsf{vec}\{\boldsymbol{\mathit{I}}_{\mathsf{L}}\}^{\mathsf{T}}\otimes\boldsymbol{\mathit{I}}_{\mathsf{M}}\right]\cdot\left[\boldsymbol{\mathit{I}}_{\mathsf{L}}\otimes\left(\boldsymbol{J}(\boldsymbol{p}+\Delta\boldsymbol{p})\cdot\Delta\boldsymbol{p}\right)\right]$$

1st order Taylor approximation of A-Scan p = [x, 0]

$$\mathbf{h}_l(x) \approx \mathbf{h}_l(x + \Delta x) - \mathbf{h}_l'(x + \Delta x) \cdot \Delta x$$

Problems:

- Acquisition of Δx
- Limited validity range
- \Rightarrow iterative estimation and correction of Δx

$$\min_{\Delta x} \|\boldsymbol{h}_{l}(x + \Delta x) - \boldsymbol{h}_{l}(x) - \boldsymbol{h}_{l}'(x + \Delta x) \cdot \Delta x\|_{2}$$



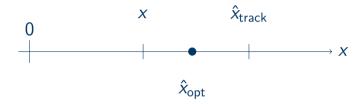
- (1) Calculate $\mathbf{h}_l(\hat{x}_{opt})$
- (2) Solve the least square problem and obtain $\Delta x_{\rm est}$
- (3) Update $\hat{x}_{\text{opt}} = \hat{x}_{\text{opt}} \Delta x_{\text{est}}$
- ** Break, when $\|\boldsymbol{h}_{l}(x) \boldsymbol{h}_{l,\text{opt}}(\hat{x}_{\text{opt}}; \Delta x_{\text{opt}})\|_{2} \leq \text{target}$



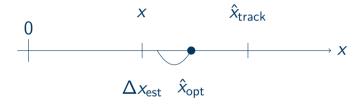
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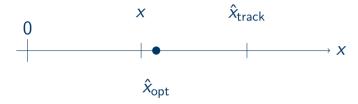
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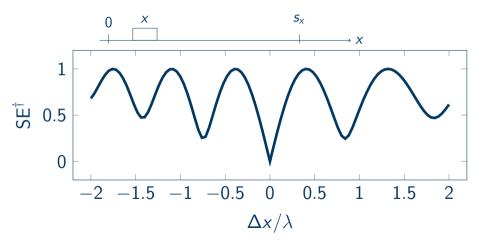
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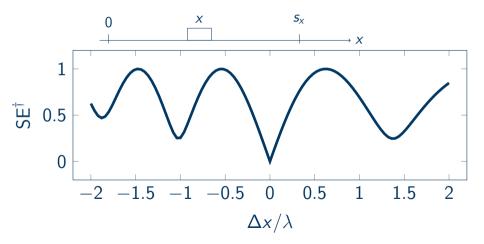
Normalized Squared Error SE[†]

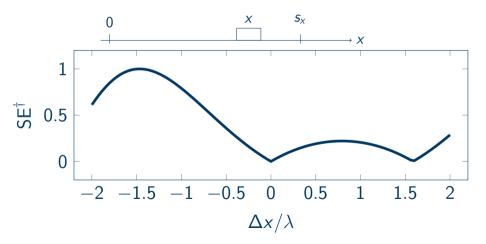
$$\mathsf{SE}^\dagger = \frac{\|\gamma \tilde{\boldsymbol{a}} - \boldsymbol{a}\|_2}{\|\boldsymbol{a}\|_2}$$

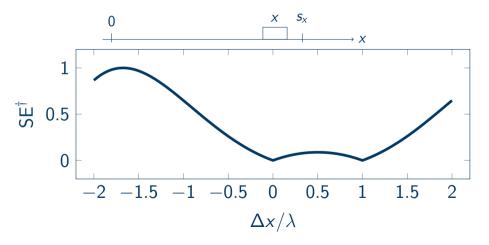
 γ : normalization factor

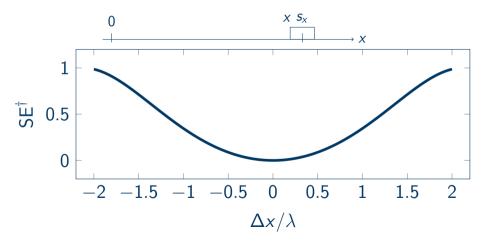
$$\gamma = \frac{\boldsymbol{a}^{\mathsf{T}} \cdot \tilde{\boldsymbol{a}}}{\tilde{\boldsymbol{a}}^{\mathsf{T}} \cdot \tilde{\boldsymbol{a}}}.$$



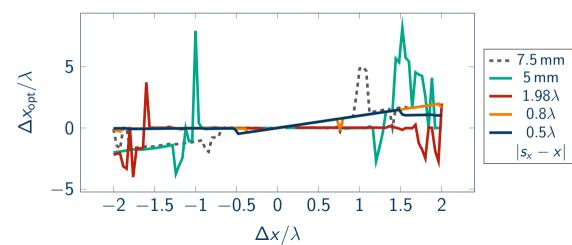




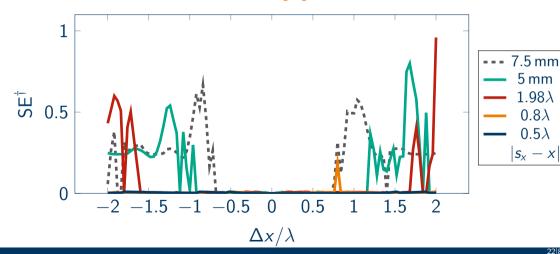




Results: Error Correction



Results: A-Scan Approximation



 0.8λ 0.5λ

SAFT reconstruction

FWM: $defect map \rightarrow A-Scan$

$$\hat{a}(p) = H(p) \cdot b$$

$$M = M \times L = L$$

FWM: $defect map \rightarrow all A-Scans$

$$\mathsf{vec}\{m{A}\} = m{\mathcal{H}} \cdot m{b}$$

$$L$$
 $L \times L$ L

SAFT reconstruction

FWM: $defect map \rightarrow all A-Scans$

$$\mathsf{vec}\{oldsymbol{A}\} = oldsymbol{\mathcal{H}} \cdot oldsymbol{b}$$
 L \times L L

Reconstruction: all A-Scans → reconstructed *defect map*

$$\tilde{\boldsymbol{b}} = \boldsymbol{\mathcal{H}}^\mathsf{T} \cdot \mathsf{vec}\{\boldsymbol{A}\}$$